QUAD/DUAL P-CHANNEL MATCHED MOSFET ARRAY

GENERAL DESCRIPTION

The ALD1107/ALD1117 are monolithic quad/dual P-channel enhancement mode matched MOSFET transistor arrays intended for a broad range of precision analog applications. The ALD1107/ALD1117 offer high input impedance and negative current temperature coefficient. The transistor pairs are matched for minimum offset voltage and differential thermal response, and they are designed for precision analog switching and amplifying applications in +2V to +12V systems where low input bias current, low input capacitance and fast switching speed are desired. These MOSFET devices feature very large (almost infinite) current gain in a low frequency, or near DC operating environment. The ALD1107/ALD1117 are buiiding blocks for differential amplifier input stages, transmission gates, multiplexer applications, current sources, current mirrors and other precision analog circuits.

FEATURES

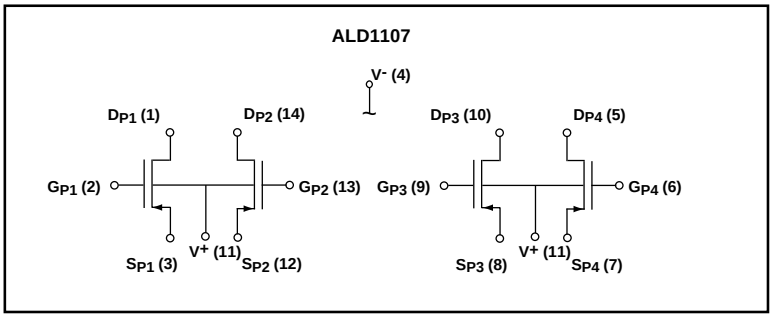
- Low threshold voltage of -0.7
- Low input capacitance
- Low V_{OS} 2mV typical
- High input impedance -- $10^{14}\Omega$ typical
- Low input and output leakage currents
- Negative current (I_{DS}) temperature coefficient
- Enhancement-mode (normally off)
- DC current gain 10^9
- Low input and output leakage currents

ORDERING INFORMATION

Operating Temperature Range*		
-55°C to +125°C	0°C to +70°C	0°C to +70°C
8-Pin CERDIP Package	8-Pin Plastic Dip Package	8-Pin SOIC Package
ALD1117 DA	ALD1117PA	ALD1117 SA
14-Pin CERDIP Package	14-Pin Plastic Dip Package	14-Pin SOIC Package
ALD1107 DB	ALD1107 PB	ALD1107 SB

* Contact factory for industrial temperature range.

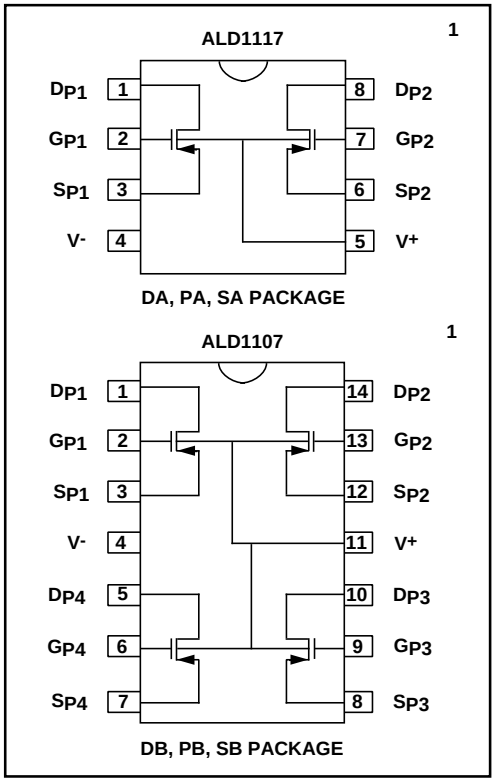
BLOCK DIAGRAM



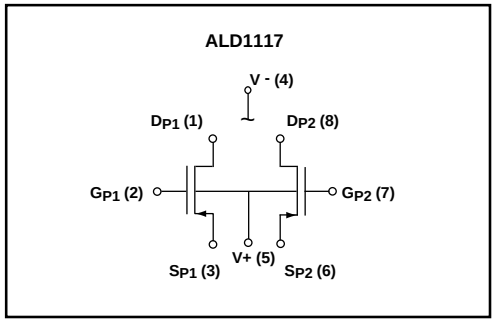
APPLICATIONS

- Precision current sources
- Precision current mirrors
- Voltage Choppers
- Differential amplifier input stage
- Voltage comparator
- Data converters
- Sample and Hold
- Precision analog signal processing

PIN CONFIGURATION



BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Drain-source voltage, V_{DS} ——— -13.2V
Gate-source voltage, V_{GS} ——— -13.2V
Power dissipation ——— 500 mW
Operating temperature range PA, SA, PB, SB package ——— 0°C to +70°C
DA, DB package ——— -55°C to +125°C
Storage temperature range ——— -65°C to +150°C
Lead temperature, 10 seconds ——— +260°C

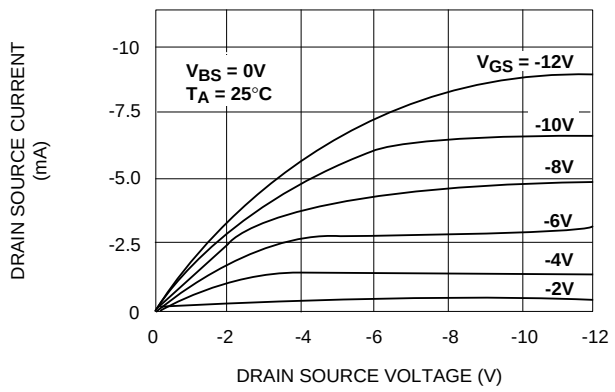
OPERATING ELECTRICAL CHARACTERISTICS
T_A = 25°C unless otherwise specified

Parameter	Symbol	ALD1107 Min	ALD1107 Typ	ALD1107 Max	ALD1117 Min	ALD1117 Typ	ALD1117 Max	Unit	Test Conditions
Gate Threshold Voltage	V_T	-0.4	-0.7	-1.0	-0.4	-0.7	-1.0	V	I_{DS} = -1.0μA V_{GS} = V_{DS}
Offset Voltage V_{GS1}-V_{GS2}	V_{OS}		2	10		2	10	mV	I_{DS} = -10μA V_{GS} = V_{DS}
Gate Threshold Temperature Drift [2]	TC_{VT}		-1.3			-1.3		mV/°C	
On Drain Current	$I_{DS (ON)}$	-1.3	-2		-1.3	-2		mA	V_{GS} = V_{DS} = -5V
Transconductance	G_{IS}	0.25	0.67		0.25	0.67		mmho	V_{DS} = -5V I_{DS} = -10mA
Mismatch	ΔG_{fs}		0.5			0.5		%	
Output Conductance	G_{OS}		40			40		μmho	V_{DS} = -5V I_{DS} = -10mA
Drain Source On Resistance	$R_{DS (ON)}$		1200	1800		1200	1800	Ω	V_{DS} = -0.1V V_{GS} = -5V
Drain Source On Resistance Mismatch	$\Delta R_{DS (ON)}$		0.5			0.5		%	V_{DS} = -0.1V V_{GS} = -5V
Drain Source Breakdown Voltage	BV_{DSS}	-12			-12			V	I_{DS} = -1.0μA V_{GS} = 0V
Off Drain Current [1]	$I_{DS (OFF)}$		10	400 4		10	400 4	pA nA	V_{DS} = -12V V_{GS} = 0V T_A = 125°C
Gate Leakage Current	I_{GSS}		0.1	10 1		0.1	10 1	pA nA	V_{DS} = 0V V_{GS} = -12V T_A = 125°C
Input Capacitance [2]	C_{ISS}		1	3		1	3	pF	

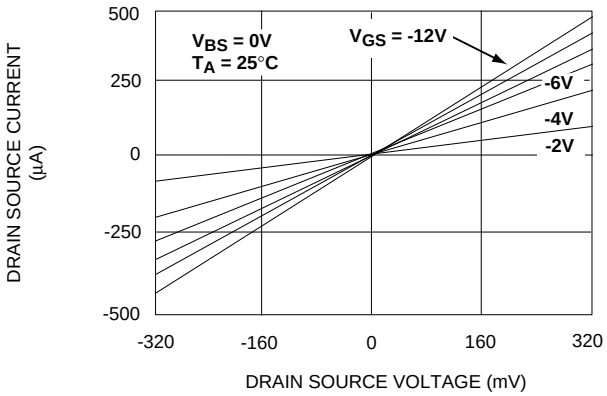
Notes: [1] Consists of junction leakage currents
[2] Sample tested parameters

TYPICAL PERFORMANCE CHARACTERISITCS

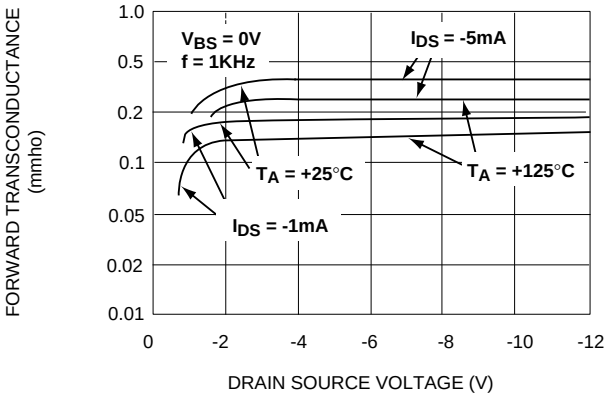
OUTPUT CHARACTERISTICS



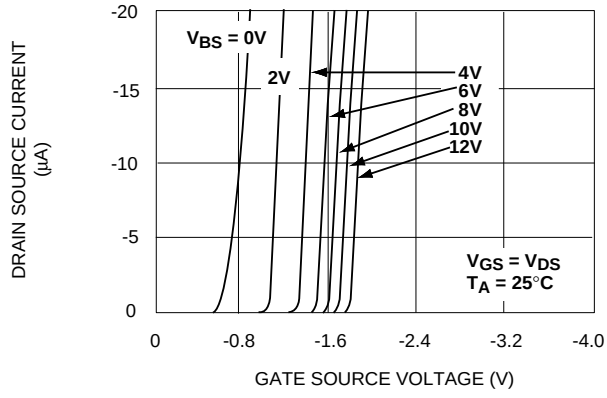
LOW VOLTAGE OUTPUT CHARACTERISTICS



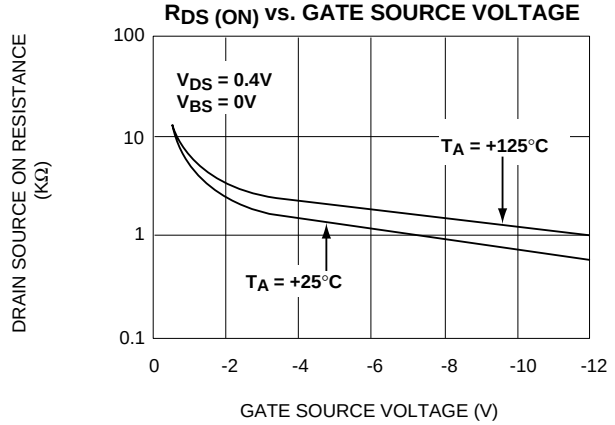
FORWARD TRANSCONDUCTANCE vs. DRAIN SOURCE VOLTAGE



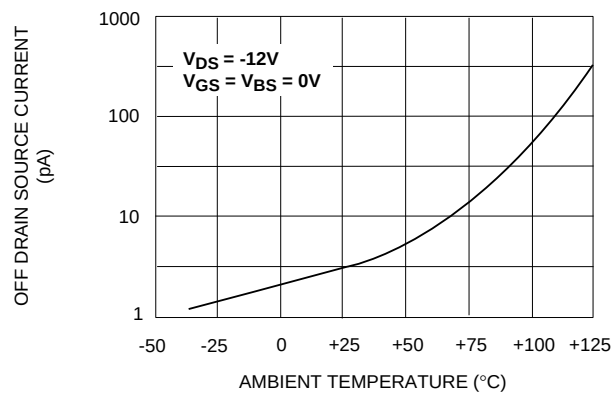
TRANSFER CHARACTERISTIC WITH SUBSTRATE BIAS



DRAIN SOURCE ON RESISTANCE $R_{DS\ (ON)}$ vs. GATE SOURCE VOLTAGE

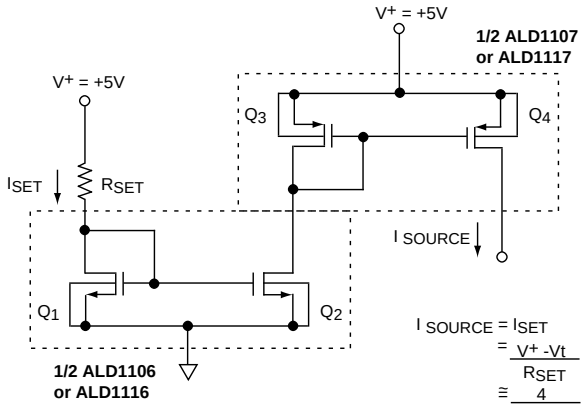


OFF DRAIN CURRENT vs. AMBIENT TEMPERATURE



TYPICAL APPLICATIONS

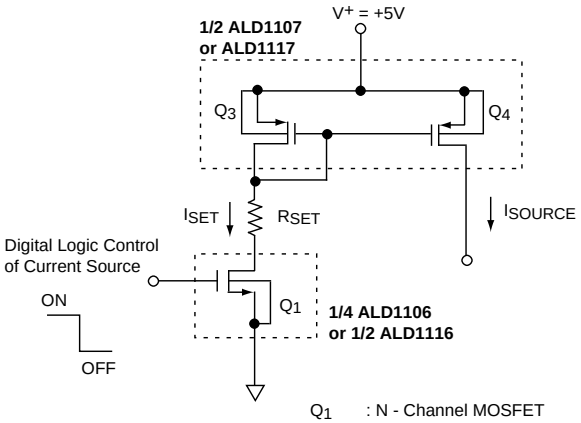
CURRENT SOURCE MIRROR



$I_{SOURCE} = I_{SET} = \frac{V^+ - Vt}{R_{SET}} \cong \frac{4}{R_{SET}}$

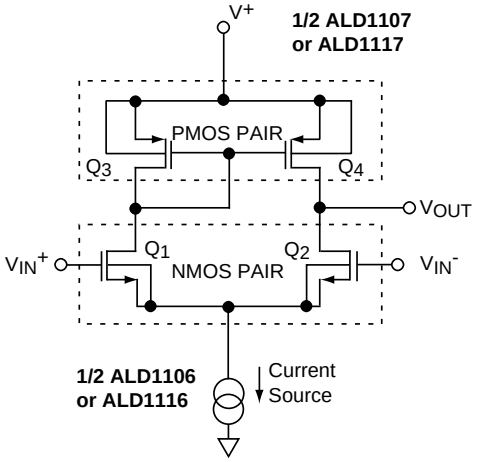
Q_1, Q_2: N - Channel MOSFET
Q_3, Q_4: P - Channel MOSFET

CURRENT SOURCE WITH GATE CONTROL



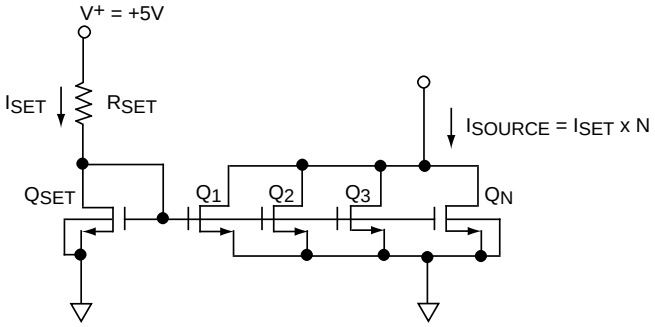
Q_1 : N - Channel MOSFET
Q_3,Q_4 : P - Channel MOSFET

DIFFERENTIAL AMPLIFIER



Q_1, Q_2: N - Channel MOSFET
Q_3, Q_4: P - Channel MOSFET

CURRENT SOURCE MULTIPLICATION

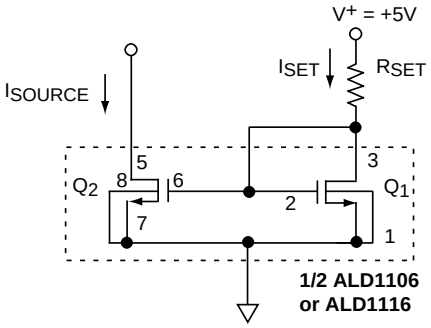


Q_{SET}, Q_1..Q_N: ALD1106 or ALD1116
N - Channel MOSFET

TYPICAL APPLICATIONS

BASIC CURRENT SOURCES

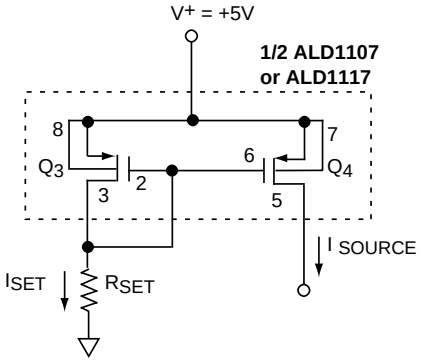
N- CHANNEL CURRENT SOURCE



$$I_{SOURCE} = I_{SET} = \frac{V^+ - Vt}{R_{SET}} \cong \frac{V^+ - 1.0}{R_{SET}} \cong \frac{4}{R_{SET}}$$

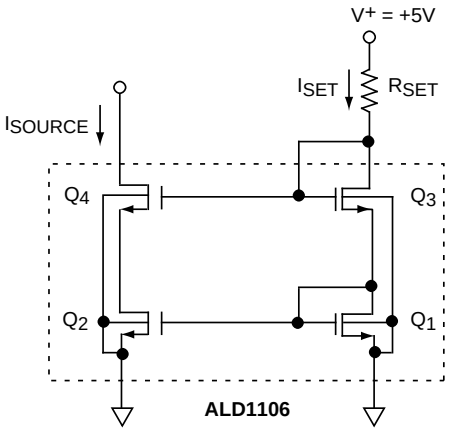
Q_1, Q_2 : N - Channel MOSFET

P- CHANNEL CURRENT SOURCE

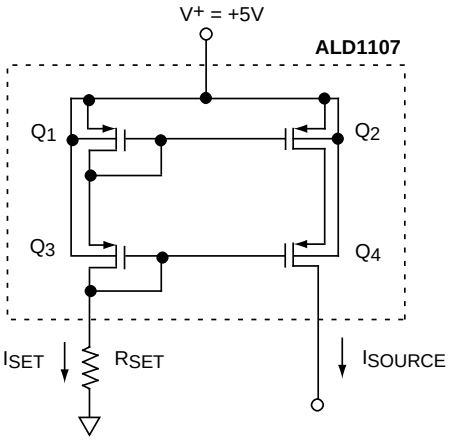


Q_3, Q_4: P - Channel MOSFET

CASCODE CURRENT SOURCES



Q_1, Q_2, Q_3, Q_4: N - Channel MOSFET
(ALD1101 or ALD1103)



$$I_{SOURCE} = I_{SET} = \frac{V^+ - 2Vt}{R_{SET}} \cong \frac{3}{R_{SET}}$$

Q1, Q2, Q3, Q4: P - Channel MOSFET
(ALD1102 or ALD1103)